Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/743,303	HAN, CHEUL KYUNG
Examiner	Art Unit

2627

Joseph Haley

	SEAR	SEARCHED Subclass Date Examiner			
Class	Subclass	Date	Examiner		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
see updated EAST search notes	10/30/2007	JRH	
